

<b>Notice of References Cited</b>	Application/Control No. 10/074,888	Applicant(s)/Patent Under Reexamination SCHWARTZ ET AL.	
	Examiner DuyVu n Deo	Art Unit 1765	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	K	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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